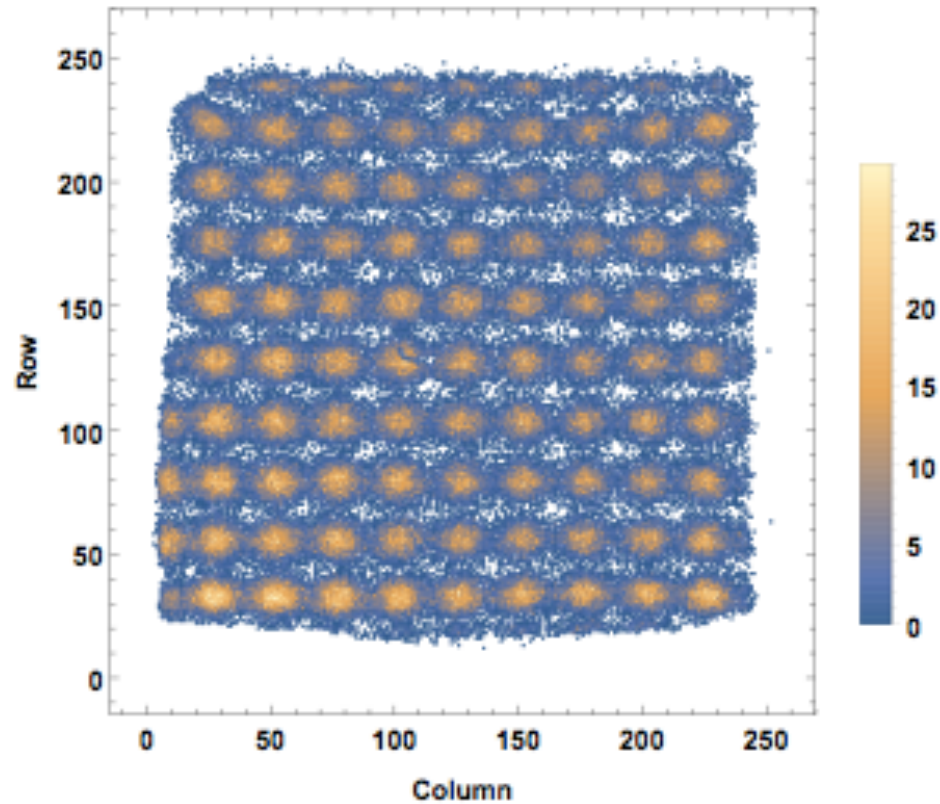


Laser data analysis



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Lepton Collider meeting Nikhef February



Laser data analysis

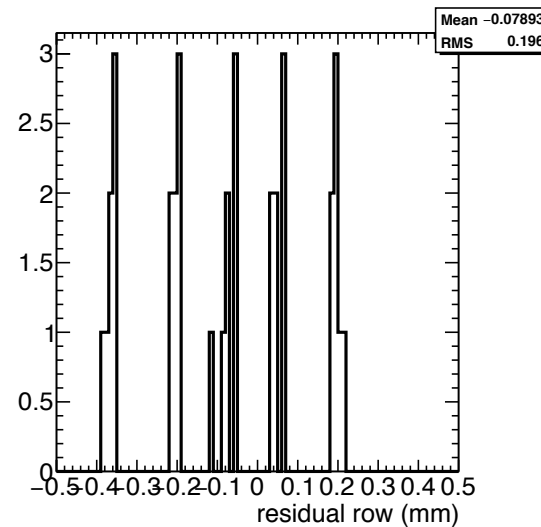
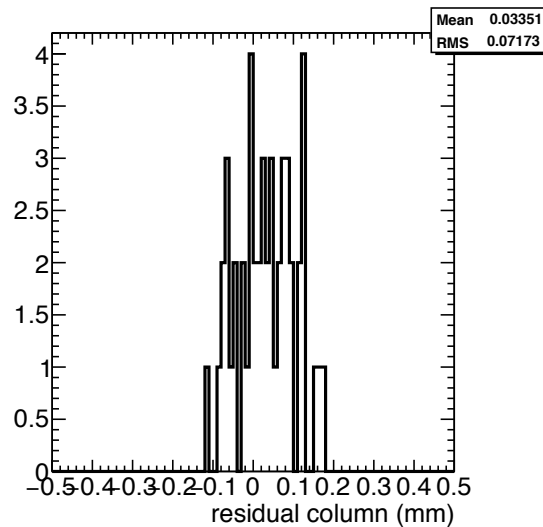
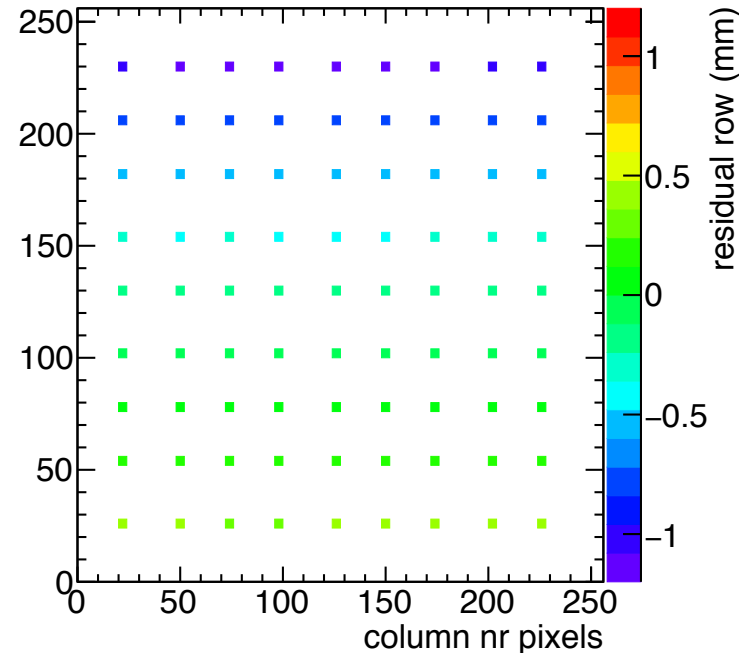
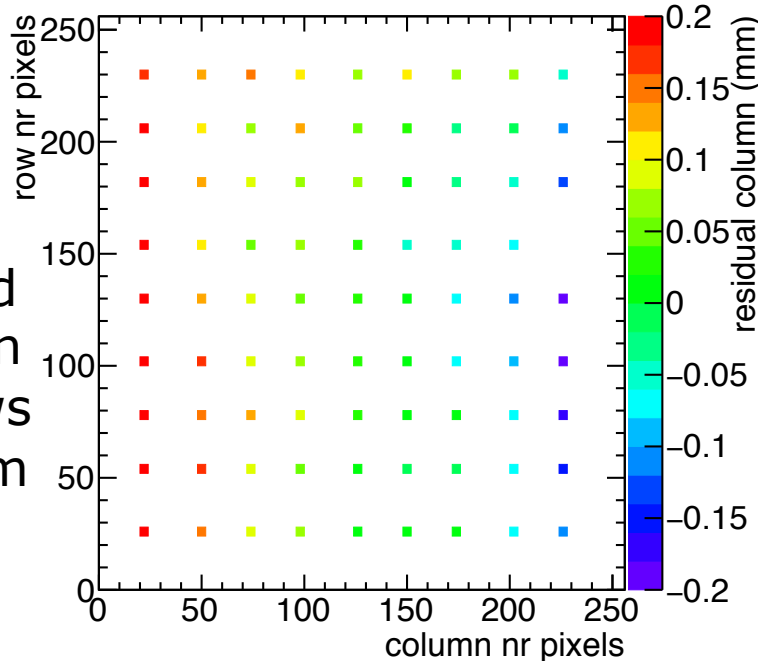
Here data at a laser height above the chip of 20 mm

note the z scales

Large Efield deformations in the rows up to -1 mm

Residual = chip average - laser position

rms cols 70 μm

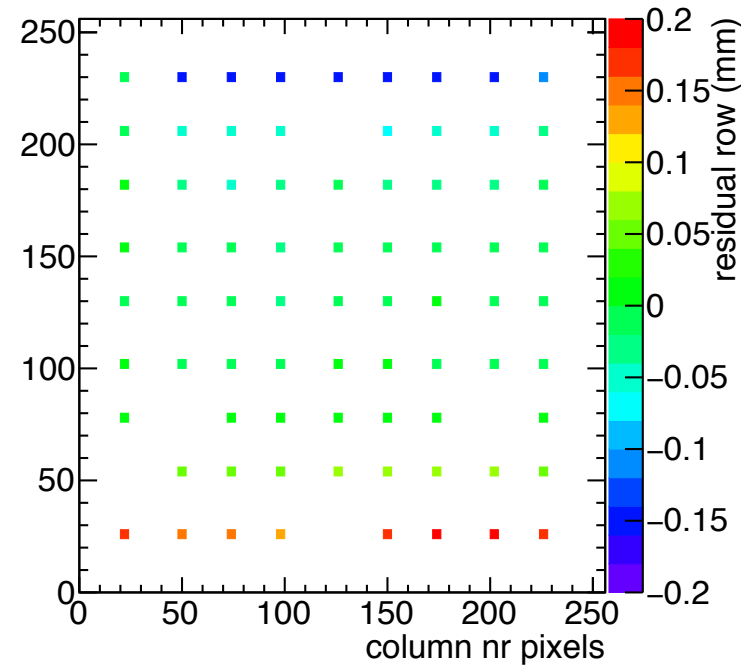
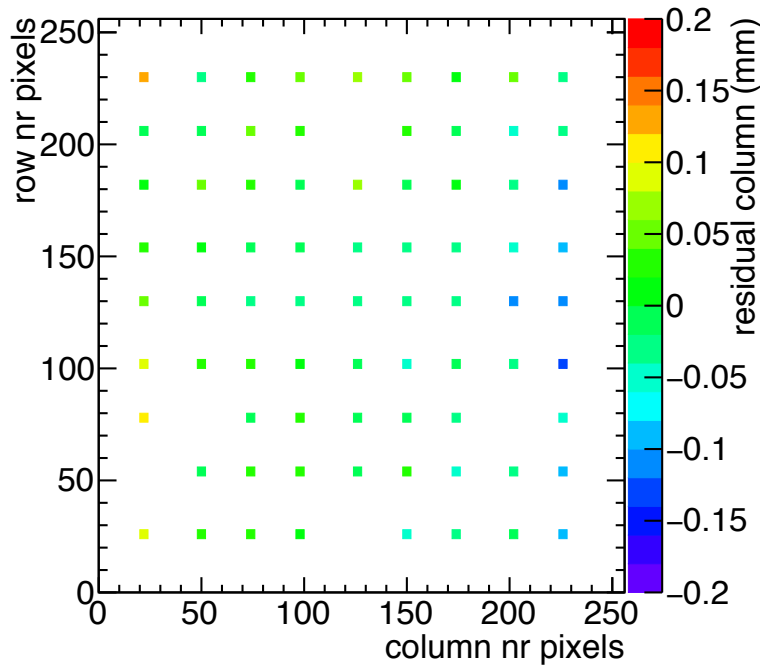


Laser data analysis

Here data at a laser height above the chip of 8 mm

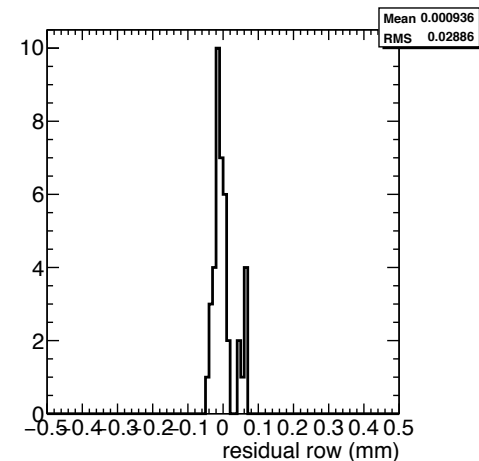
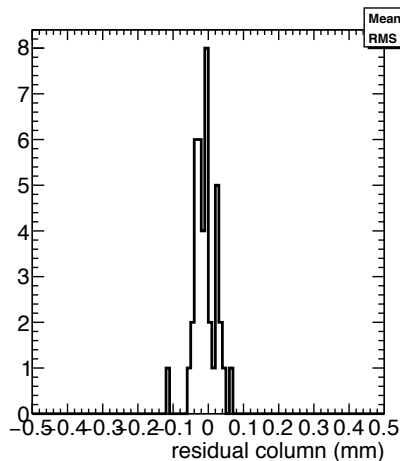
note the
scale 0.2

small Efield
deformations
at edges of
chip of 0.2
mm



Removing the edge rms
30 μm columns and rows

So closer to chip the
deformations are small

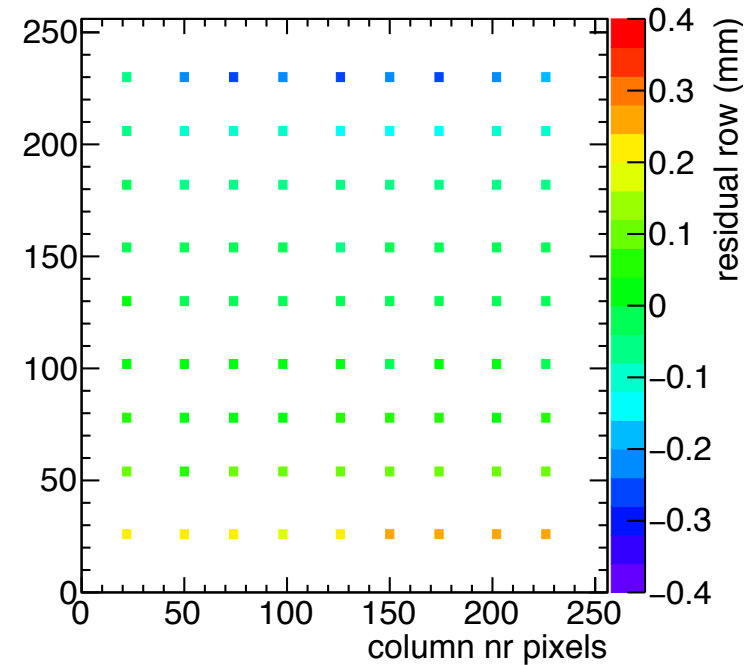
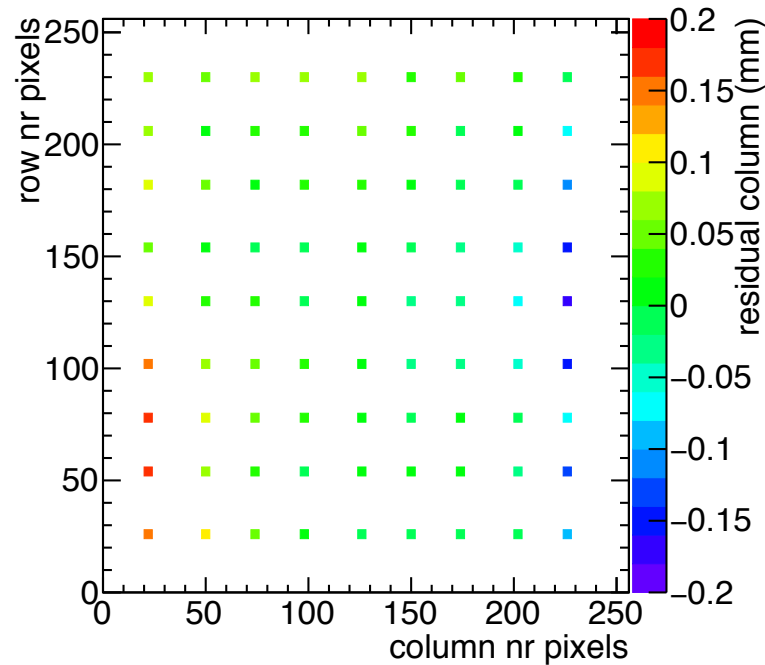


Laser data analysis

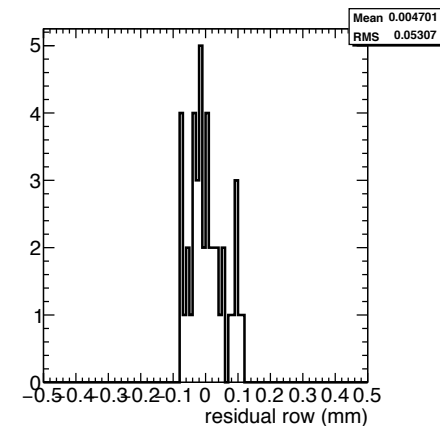
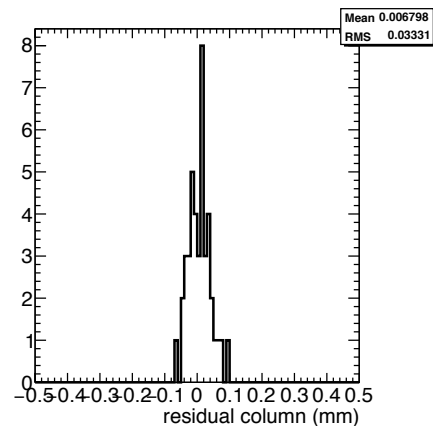
Here data at a laser height above the chip of 10 mm

note the
scale 0.4

small Efield
deformation
s edges of
chip of 0.4
mm



So going from 8 to 10 mm
height the row residuals
increase due to field
distortions





Conclusions

Laser data analysis

There is a problem with field definition for large laser heights (20 mm) that affects the row residuals.

Going to small heights shows that the deformations are reduced: the edge columns and rows are shifted by at most 0.2 mm.

The rms of the distribution (removing the edges) is 30 μm . This is pretty good.